A Finite Element Approach to X-ray Optics Design

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Introduction

Dynamical diffraction in a deformed (often bent) crystal is described by the Takagi equations\textsuperscript{1} which, in general, have to be solved numerically on a regular 2-D grid of points representing a planar cross section of the crystal in which the diffraction of an incident X-ray wavefront occurs. Presently, the majority of numerical approaches are based on a finite difference solving scheme\textsuperscript{2-4} which can be easily implemented on a regular Cartesian grid but is not suitable for deformed meshes. In this case, the inner deformed crystal structure can be taken into account, but not the shape of the crystal surface if this differs substantially from a planar profile\textsuperscript{5,6}.

Conversely, a finite element method (FEM) can be easily applied to a deformed mesh and serves very well to the purpose of modelling any incident wave on an arbitrarily shaped entrance surface\textsuperscript{7} e.g. that of a bent crystal or a crystal submitted to a strong heat load\textsuperscript{8-10}. For instance, the cylindrical shape of the surface of a strongly bent crystal plate can easily be taken into account in a FEM calculation. Bent crystals are often used as focusing optical elements in X-ray beamlines\textsuperscript{11-13}.

In the following, we show the implementation of a general numerical framework for describing the propagation of X-rays inside a crystal based on the solution of the Takagi equations via the COMSOL Multiphysics FEM software package (www.comsol.com). A cylindrically bent crystal will be taken as an example to illustrate the capabilities of the new approach.

Theoretical frame

Considering an incident wave $\Psi_{\text{inc}} = \exp(i\vec{k} \cdot \vec{r})E_{\text{inc}}(\vec{r})$ and the corresponding wave-field in a deformed crystal as $\psi(\vec{r}) = \exp(i\vec{k} \cdot \vec{r})[E_{\text{o}}(\vec{r}) + \exp(i\vec{h} \cdot \vec{r})E_{\text{i}}(\vec{r})]$ where the modulation amplitudes are slowly varying functions, it can be shown that the modified amplitudes

\begin{align}
T(s_o, s_h) &= \exp\left[i \frac{k}{2} \chi_o(s_o + s_h) -iks_h \Delta \theta \sin 2\theta_B \right]E_{\text{o}}(s_o, s_h) \\
D(s_o, s_h) &= \exp\left[i \frac{k}{2} \chi_o(s_o + s_h) -iks_h \Delta \theta \sin 2\theta_B - i\vec{h} \cdot \vec{u} \right]E_{\text{i}}(s_o, s_h)
\end{align}

(1a) (1b)
are solutions of the following Takagi equations

\[
\frac{\partial T}{\partial s_0} = i \frac{k}{2} \chi_x D \quad (2a)
\]

\[
\frac{\partial D}{\partial s_h} = -i \frac{\partial (\vec{h} \cdot \vec{u})}{\partial s_h} D + i \frac{k}{2} \chi_x T \quad (2b)
\]

In the above equations, \((s_o, s_h)\) are oblique coordinates along the directions of \(\vec{k}\) and \(\vec{k}_h = \vec{k} + \vec{h}\), respectively; \(\vec{u}(\vec{r})\) is the deformation field, \(\chi_{o,h,\vec{h}}\) are the relevant Fourier coefficients of the undeformed crystal polarizability (to be multiplied by \(\cos 2\theta_\vec{h}\) in the case of \(\sigma\) polarization); \(\theta_\vec{h}\) is the Bragg angle and \(\Delta \theta\) is the crystal misorientation from the geometrical Bragg position.

In order to numerically solve the system of equations (2a, 2b) we present a new Finite Element Method (FEM) scheme based on the following integral weak formulation of these equations:

\[
\int_\Omega d\Omega \left[ \frac{\partial \omega_i}{\partial S_o} T + i \frac{k}{2} \chi_{-\vec{h}} \omega_i D \right] - \int_\Gamma d\Gamma \vec{n} \cdot \hat{s}_{o,i} \omega_i T = 0 \quad (3a)
\]

\[
\int_\Omega d\Omega \left[ \frac{\partial \omega_i}{\partial S_h} D + i \frac{k}{2} \chi_{\vec{h}} T + i \frac{\partial (\vec{h} \cdot \vec{u})}{\partial S_h} D \right] - \int_\Gamma d\Gamma \vec{n} \cdot \hat{s}_{o,i} \omega_i D = 0 \quad (3b)
\]

where \(\omega_i(\vec{r})\) is a set of test functions; \(\hat{s}_{o,h}\) are unit vectors in the \(s_{o,h}\) directions. The FEM code generates a mesh of 2-D elements (generally triangles) adapted to the geometry of the integration domain \(\Omega\) with boundary \(\Gamma\). The boundary conditions are included in the boundary line integrals.

In the chosen discretization scheme, a linear shape function \(N_i(\vec{r})\) is associated to each knot \((i)\) of the mesh, ranging from the value 1 at the knot \((i)\) to 0 on the polygonal line formed by the other knots that are apices of the triangles sharing \((i)\) as apex. Test functions analogous to the chosen shape functions can be used. An approximate solution in the form \(T(\vec{r}) = \sum_i T_i N_i(\vec{r})\) and \(D(\vec{r}) = \sum_i D_i N_i(\vec{r})\), with coefficients \(T_i\) and \(D_i\) to be numerically determined, is calculated.

From this solution, it is in general necessary to use the relations (1a, 1b) to obtain the physically significant amplitudes \(E_{o,h}(\vec{r})\). This is essential for the simulation of the focusing effect considered hereafter.
**Numerical simulations**

We present FEM simulations of reflectivity curves of a flat undeformed crystal (Figs. 1 and 2) and of a cylindrically bent crystal (Fig. 3), both in symmetric Bragg geometry, as well as the related focusing properties, as implemented by using COMSOL. We consider a monochromatic point source in all cases. The Cartesian components of the displacement field, with the $z$-axis along the inward normal to the plate surface, are $U_z = x(z - t/2)/R$ and $U_z = -[x^2 + \nu(z - t/2)^2]/2R$, where $R$ is the bending radius, $t$ is the plate thickness and the Poisson ratio was chosen to be $\nu = 0.27$.

The source-to-crystal distance $p$ is varied by using $E_{\text{inc}}(x) = \exp[ik(x \sin \theta_B)^2/2 - p - x^2/w^2]$ on the crystal surface. The curved shape of the surface of the bent crystal is taken into account in the FEM simulation: we have verified that the results do not change significantly if this surface is considered to be flat.

Fig. 1 FEM simulation, using a triangular grid size of 1 $\mu$m, of the (Si111, E=8 Kev) reflectivity curve (RC) of a 100 $\mu$m thick undeformed crystal plate in symmetric Bragg geometry, compared to...
the output of the XOP INPRO program taken as a reference\textsuperscript{14}. In the COMSOL simulation, the footprint of the incident plane wave on the crystal surface is modulated by a Gaussian window ($\sigma = w/\sqrt{\ln 2} = 100 \ \mu m$) implying the boundary condition:

$$T(x, z = 0) = \exp[i k x (\Delta \theta \sin 2\theta_B + \chi_v \cos \theta_B) - x^2 / w^2]$$

on the crystal surface.

Fig2. RC simulation as in fig.1, but with two different grid sizes, showing that a grid size as small as 1 \(\mu\)m is necessary to obtain reliable results; the accuracy can also be improved by using a “boundary layer option” available in COMSOL.
Fig. 3. RC simulations of the (Si111, 7 Kev) of 5 μm thick cylindrically bent crystal plate (bending radius $R = 5$ m) in symmetric Bragg geometry for different source-to-crystal distances. The extinction length (0.735 μm) in this case is much smaller than the plate thickness. The other parameters are reported in the title of the Figs. 4a and 4b display the maps of the total intensities inside a bent crystal ($R = 5$ m) for two cases: a) source on the Rowland circle (Si111, $E=8$ Kev; $p = R \sin \theta_B = 1.40$ m). b) $p = 5$m.

Fig. 4a. Map of the total intensity in the crystal illuminated by a source on the Rowland circle. Same parameters as in Fig.1. The beam penetration is limited to a very slight crystal depth.
Fig. 4b. Map of the total intensity in the crystal illuminated by a source off-Rowland circle. To be noticed: the “mirage effect”

Fig. 5 shows the reflected intensity distributions on a bent crystal surface ($R = 5$ m), in the case of the same source at different distances; the Gaussian window ($\sigma = 200$ $\mu$m) is centered at the crystal surface point corresponding to the center of the RC. The reflected intensity distribution is not very different from the incident one if the source is on the Rowland circle ($p = 1.236$ m), indicating almost total reflection as expected, with, accordingly, a small penetration range in the crystal, as shown in fig. 4a. This is no longer the case for $p = 5$ m: in this case a part of the incident wave penetrates in the crystal and is reflected back towards the surface due to the “mirage effect”\textsuperscript{15,16}. This gives rise by interference to the oscillations seen in Fig. 5. By using (1b), the reflected amplitude $E_h(s_o, s_h)$ is obtained from the reflected amplitude $D(s_o, s_h)$ provided by the solution of (2a, 2b). The distribution of $E_h(s_o, s_h)$ on the crystal surface can be projected on a plane perpendicular to the reflected direction and further propagated in free space, in order to investigate its focusing properties. The focusing distance is found to be in agreement with the lens equation $\frac{1}{p} + \frac{1}{q} = 2/R \sin \theta_h$\textsuperscript{17}. The corresponding intensity distributions in the focus position is plotted in fig. 6, for the source-to-crystal distances considered in fig. 5.
Fig. 5. Reflected intensity distributions on the crystal surface for different source-to-crystal distances compared with the incident wave intensity.
Fig. 6. Focus intensity profiles in the same conditions as in fig. 5.

Figs. 7 and 8 show surface intensity distributions for two values of the misorientation angle. Because of the refraction effect, $\Delta \theta = 0$ arcsec corresponds actually to an off-Bragg position; while $\Delta \theta = 5$ arcsec corresponds to the effective Bragg condition. In Fig. 8, the intensity oscillations are due to the part of the beam reflected by the crystal back surface. The crystal thickness is 20 $\mu$m.
Fig. 7. Reflected intensity distributions on the crystal surface. Bending radius 10 m; source on Rowland circle; Si 111, 12 Kev; red curve for $\Delta \theta = 0$, green curve for $\Delta \theta = 5$ arcsec; the blue curve represents the incident intensity.

Fig. 8: Same conditions as in Fig. 7, except that the source is at a large distance ($p = 30$ m).
Conclusions

A very general finite element approach to Takagi equations in their integral form is presented. This allows for wide flexibility in numerically simulating the X-ray propagation in both a flat and deformed crystal for any complex geometric domain. The finite element solution is computationally efficient and comparable to the finite difference method in conventional cases, where the computational domain is rectangular or, more broadly, delimited by straight lines. However, in general the deformation modifies this simple geometry and when the diffracted phase plays a crucial role, the deformed surface has to be accounted for in the calculations. In a forthcoming work we will demonstrate the phase propagation effects in air after diffraction from a crystal polychromator in Bragg geometry as simulated by our finite element code.

References


